

Search Notes

Application/Control No.

10/728,479

Examiner

Yoon-Young Kim

Applicant(s)/Patent under
Reexamination

WALTON ET AL.

Art Unit

1723

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-------------------------------------|-----------|------|
| Inventor Search | 2/24/2005 | YK |
| Consulted John Rivell 137/625.47 | 3/1/2005 | YK |
| See EAST Search History | 3/4/2005 | YK |
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